

<b>Notice of References Cited</b>	Application/Control No. 10/578,930	Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner KIBROM T. HAILU	Art Unit 2461	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,650,629	11-2003	Takahashi et al.	370/335
*	B	US-2003/0119452	06-2003	Kim et al.	455/69
	C	US-			
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	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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